

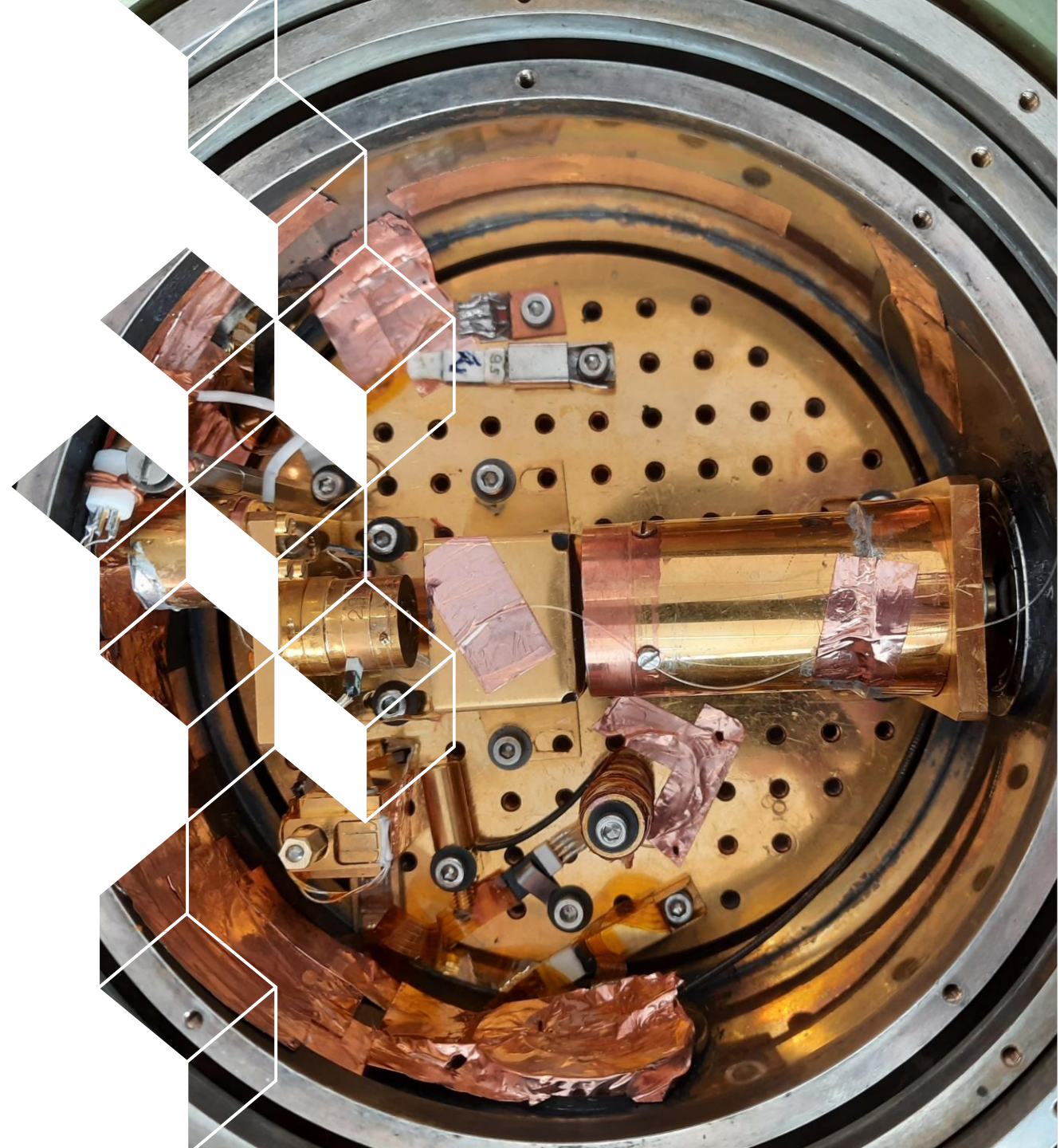


H2020 Project SANDA

WP2 : New nuclear data

Measurement of half-life and γ -ray emission probabilities of beta emitters

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Outline

Motivation

Development of cryogenic electric substitution system for HPGe calibration

More precise γ -ray emission probabilities possible

Development of a dedicated half-life measurement system

Measurement of the half-life of two radionuclides (^{51}Cr and ^{67}Ga)

Outlook and conclusions



1 ■ Precise γ -ray emission probabilities

Motivation

Accurate measurement of γ - and X-ray emission intensities, requires **well-calibrated photon spectrometers**

In the **conventional approach**, efficiency calibration is carried out by using radionuclide standards, calibrated in activity, and **previously known photon emission intensities**

$$\varepsilon(E) = \frac{N(E)}{A I(E) t} \prod_i C_i$$

$N(E)$: Net peak area t : counting time (live time) C_i : correction factors
 A : source activity $I(E)$: photon emission intensity

- Photon emission intensity measurements and efficiency calibration are strongly correlated

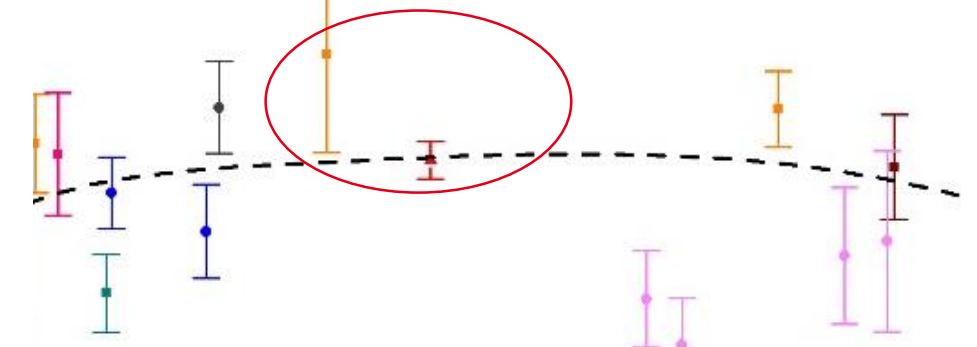
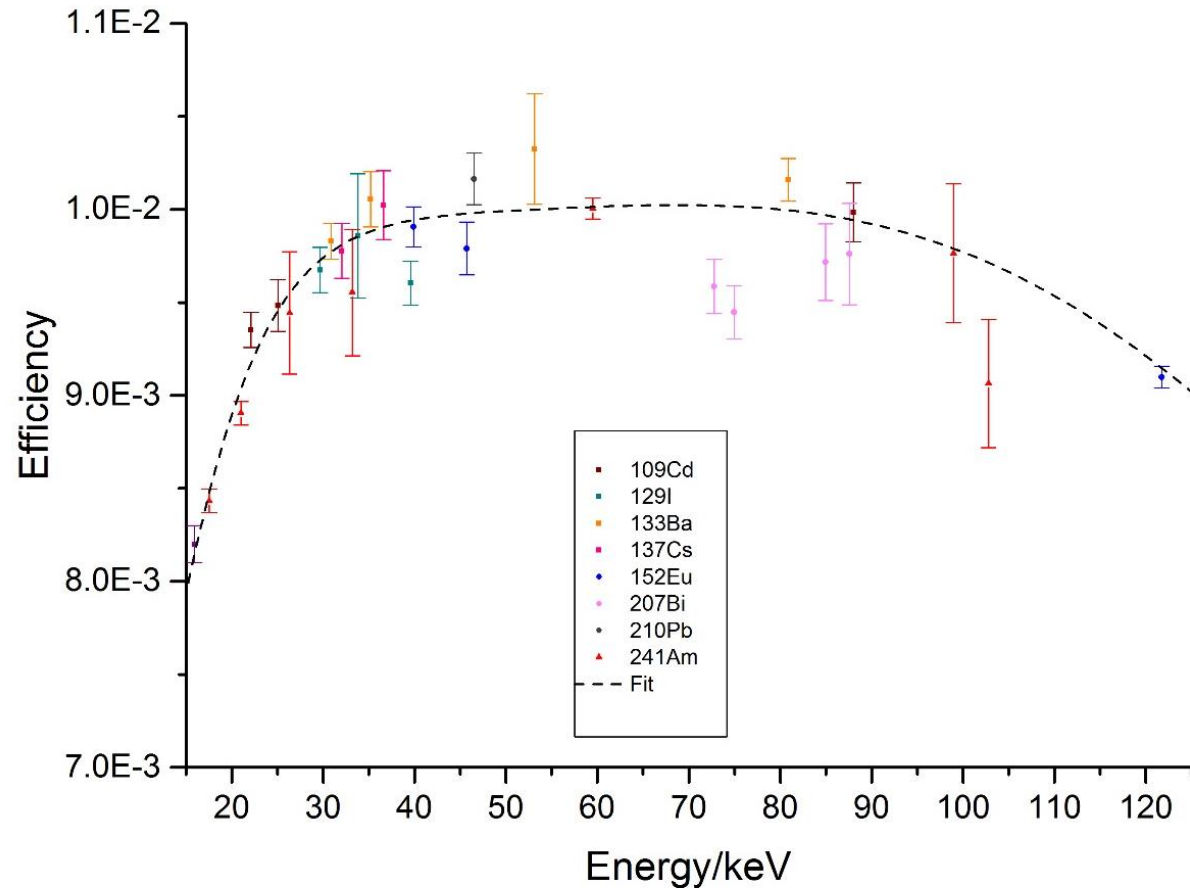
Intrinsic limitation: we rely on the same quantity we intend to measure

- Limited number of radionuclides for calibration
- Correlation between γ - and X-ray emission intensities

$$I_{XK} = P_\gamma \frac{\alpha_K}{1 + \alpha_T} \omega_K$$

Motivation

- Inconsistency in nuclear data and problems with the efficiency calibration of HPGe spectrometers below 100 keV
- e.g. systematic difference of experimental results using ^{133}Ba (53.2 keV) and ^{241}Am (59.5 keV)



Motivation

SOLUTION

Use of well-measured photon fluxes whose calibration is **independent** of any previously measured **photon emission intensities**

This approach requires
ABSOLUTE MEASUREMENT OF PHOTON FLUXES

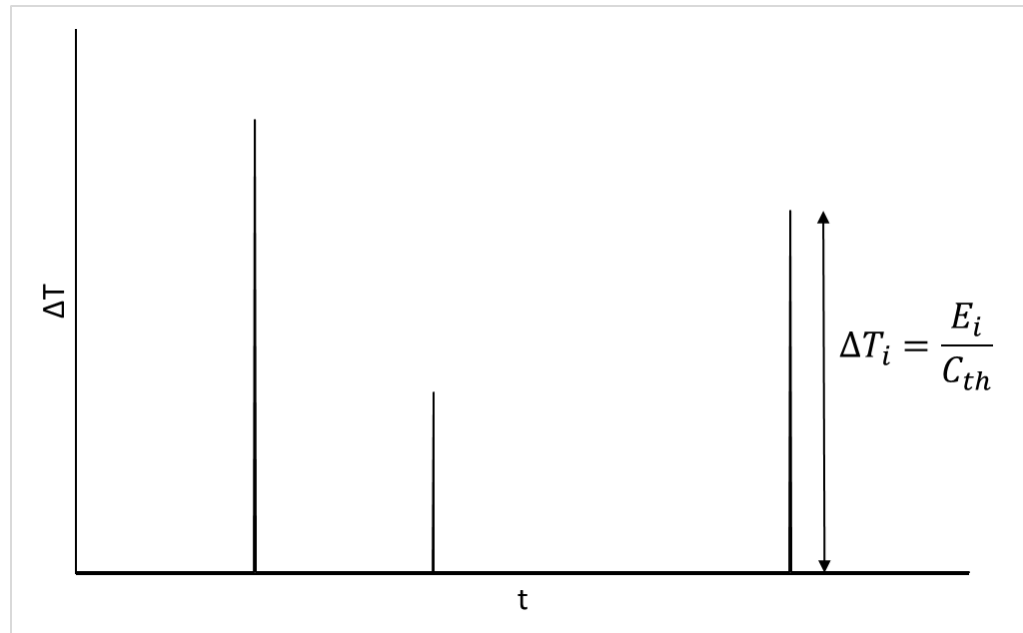


CRYOGENIC DETECTORS

Cryogenic detectors

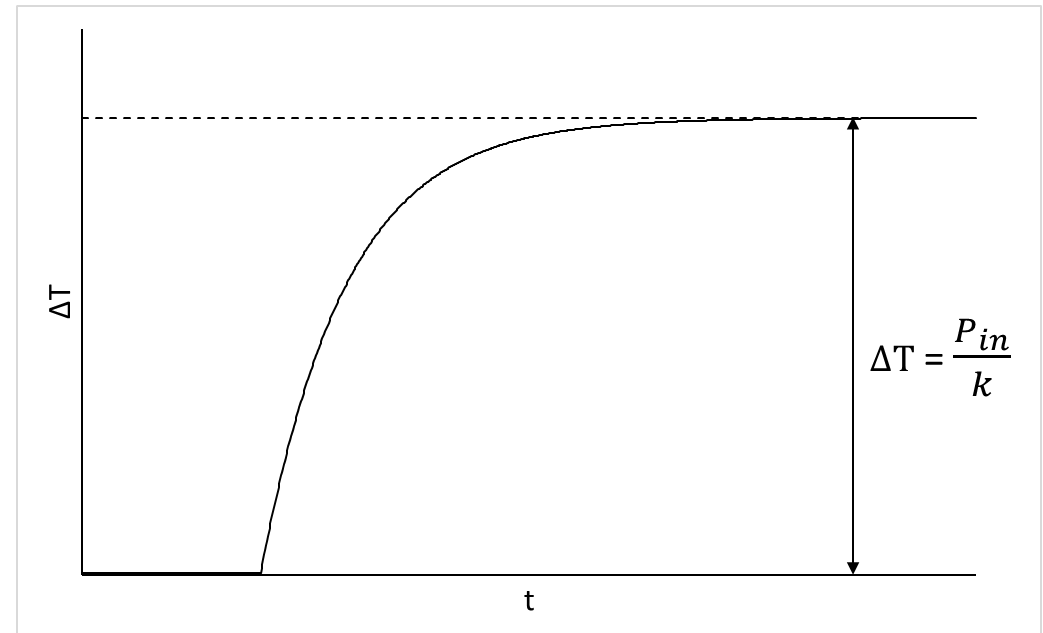
When radiation interacts with an absorber, it provokes a **temperature rise**, ΔT , which is proportional to the energy of the incident radiation

pulse mode



Allows spectroscopy

continuous mode

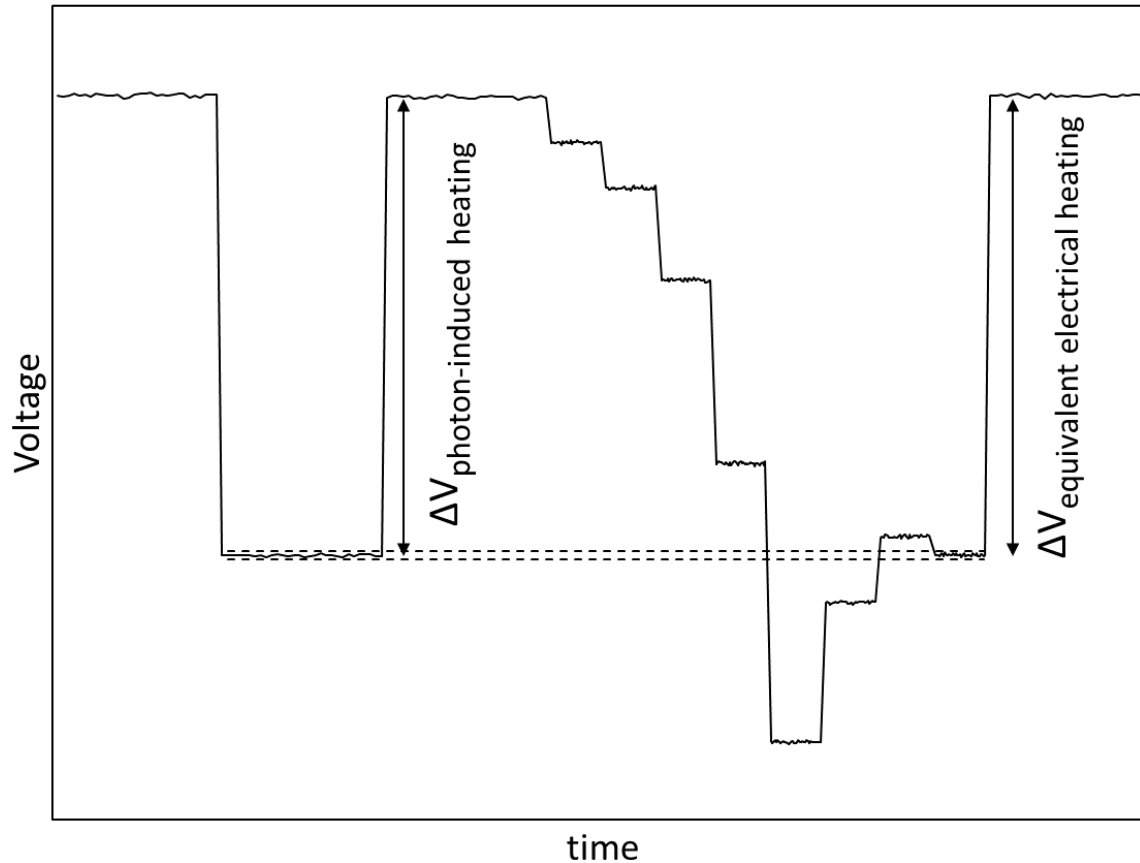


Allows measurement of high photon fluxes

Cryogenic detectors

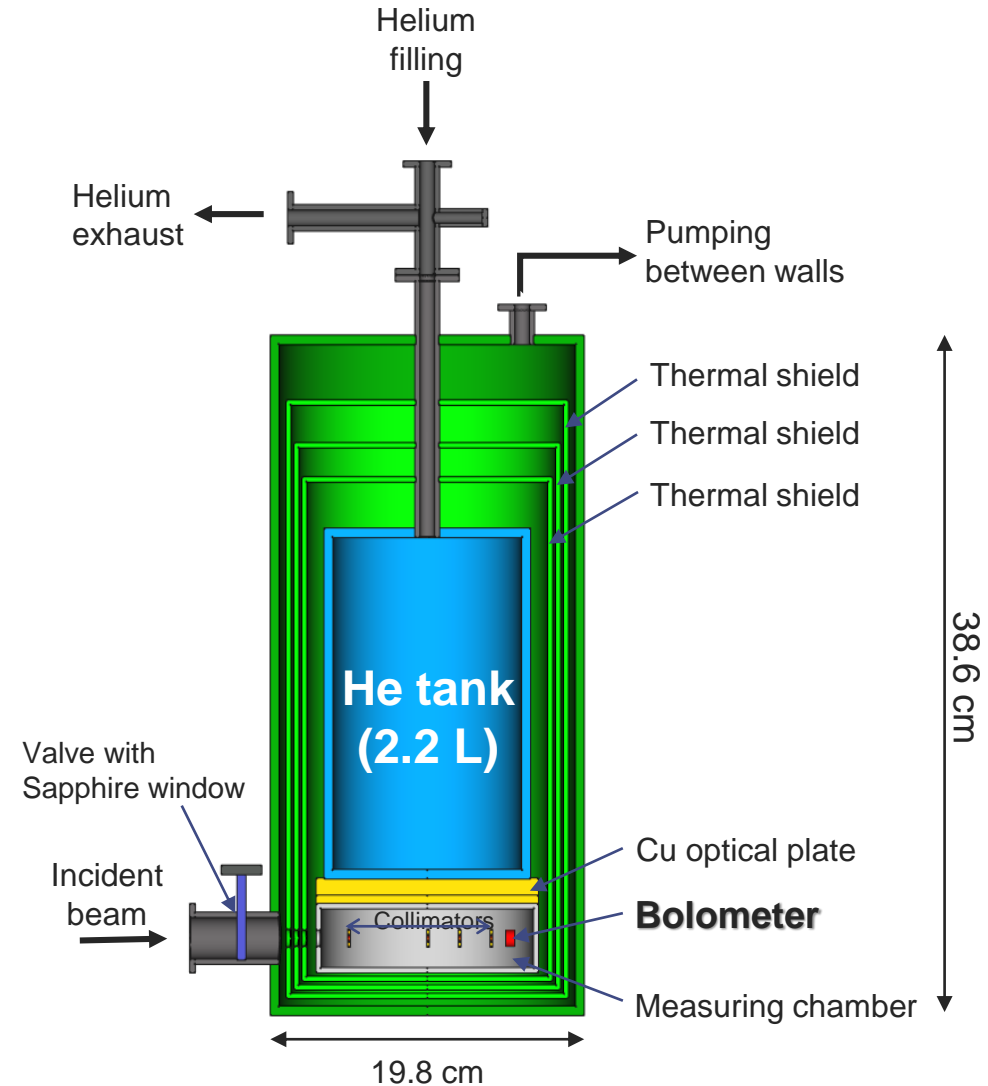
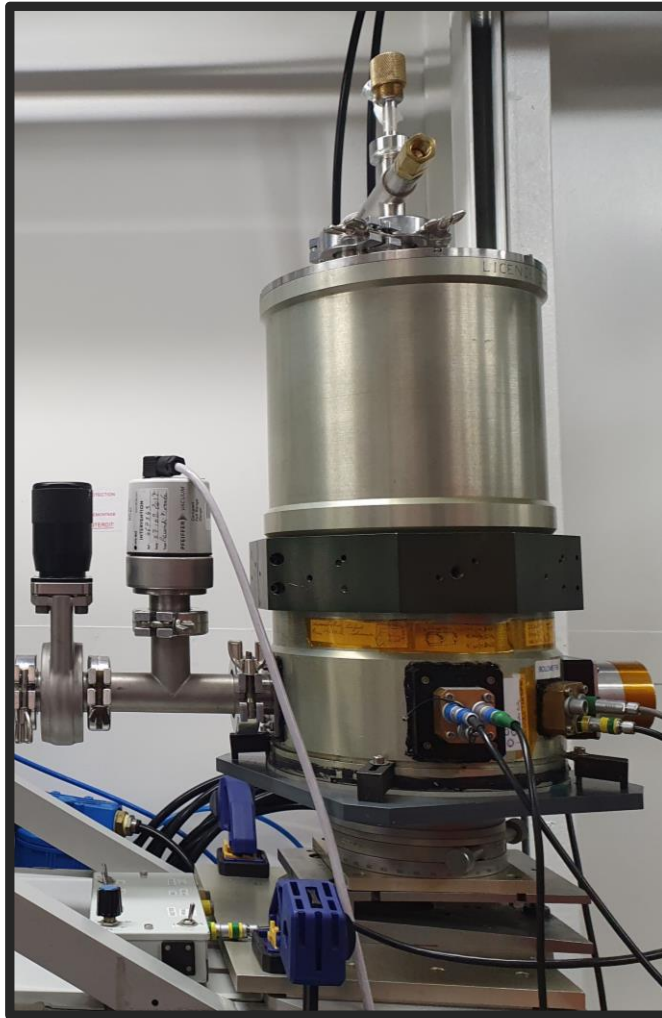


PRINCIPLE OF ELECTRICAL SUBSTITUTION



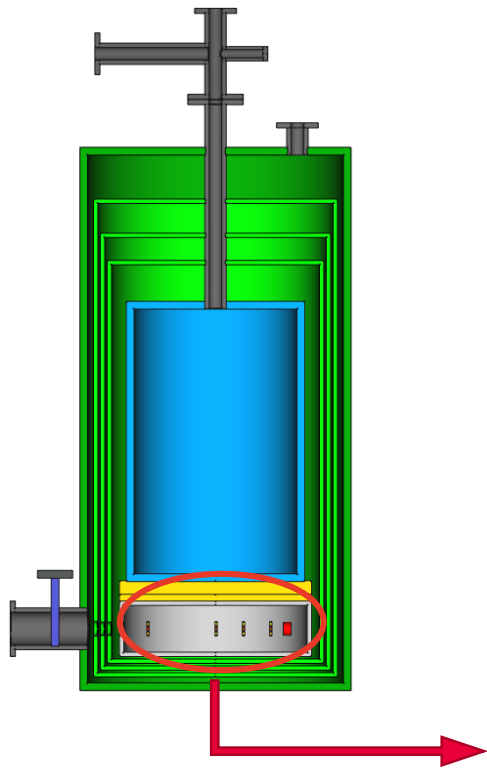
The amount of energy deposited by the radiation can be determined by finding the **electrical power** that needs to be transferred to the absorber in order to obtain **the same temperature rise**

BOLUX - BOLometer for Use in the range of X-rays

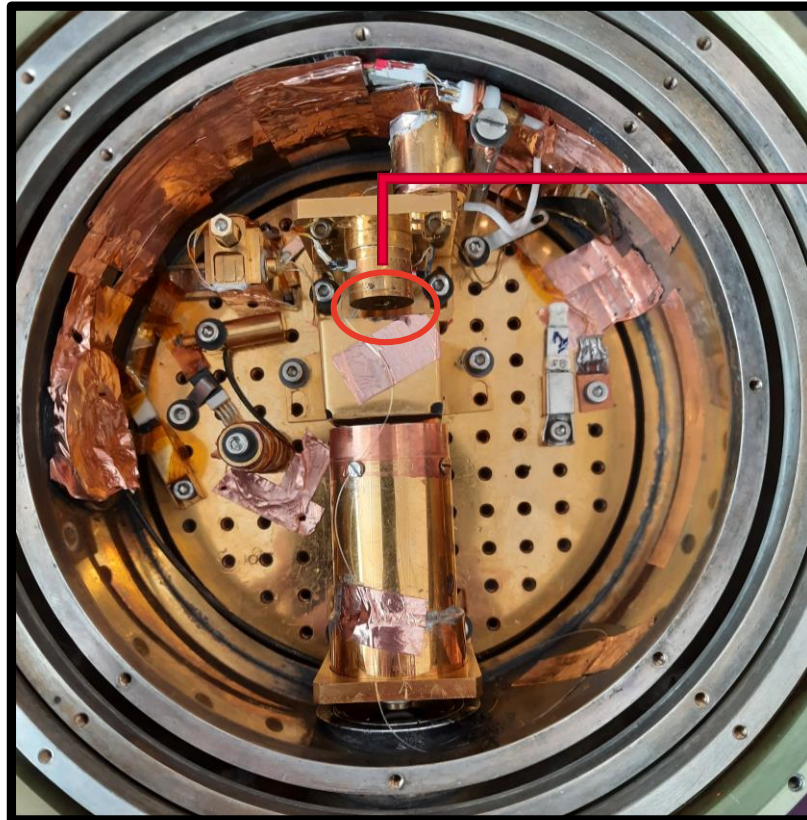


BOLUX - BOLometer for Use in the range of X-rays

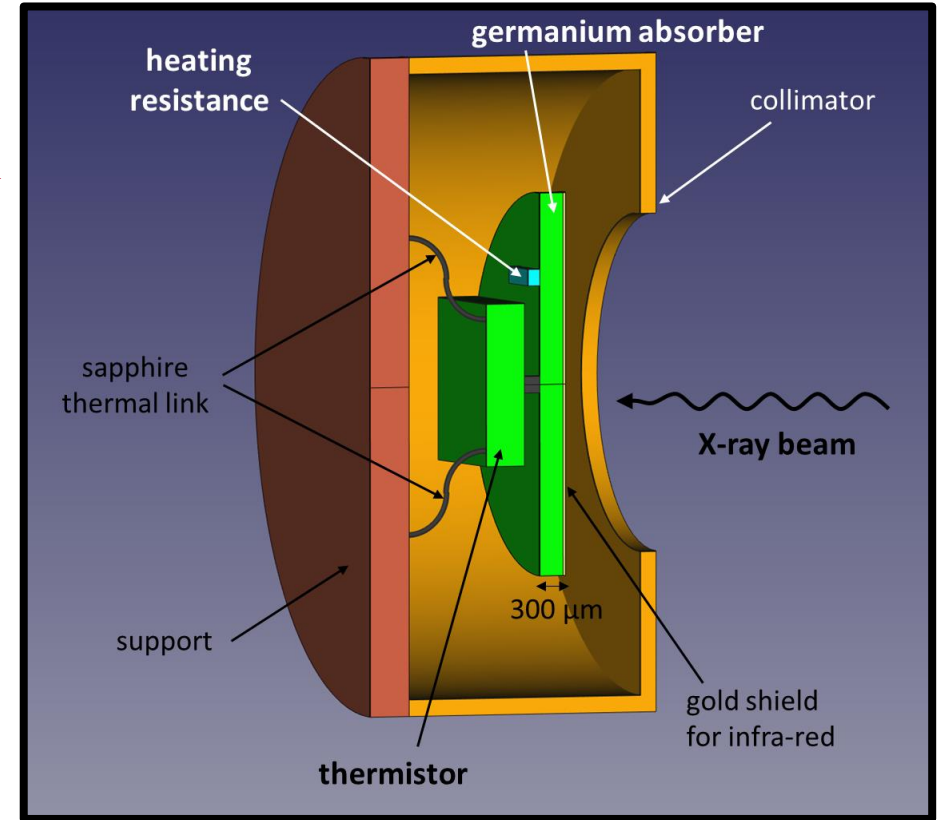
Cryostat



Measuring chamber

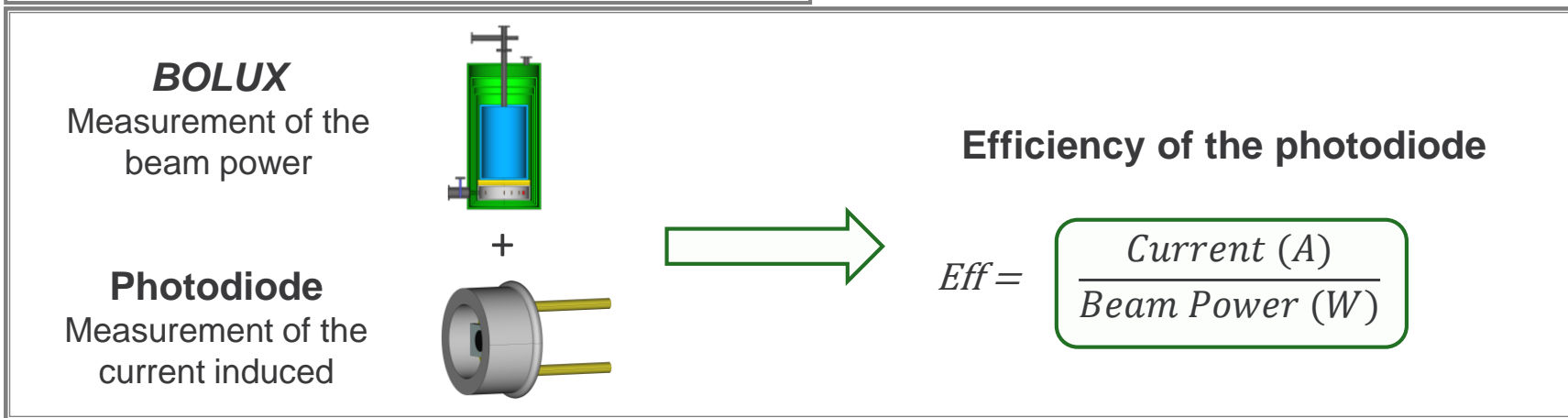


Bolometer



Measurements to calibrate a HPGe detector

1st step, with a high photon flux ($\sim 10^9$ ph/s)



The efficiency of BOLUX, the photodiode and the semiconductor detector depend on the **photon's energy**

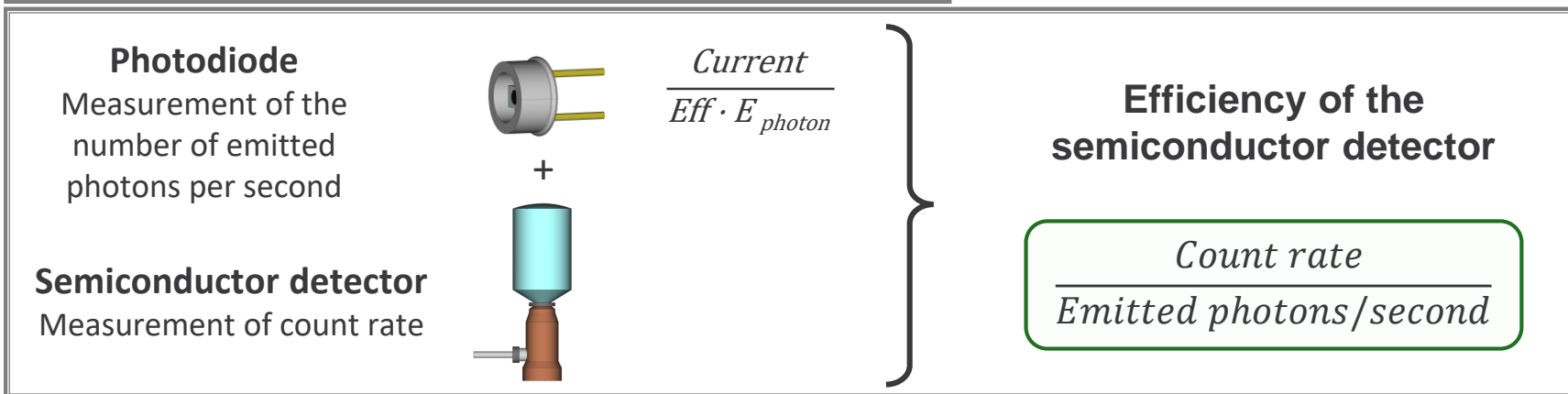
but BOLUX and the photodiode are not able to discriminate photons by energy



monochromatic radiation



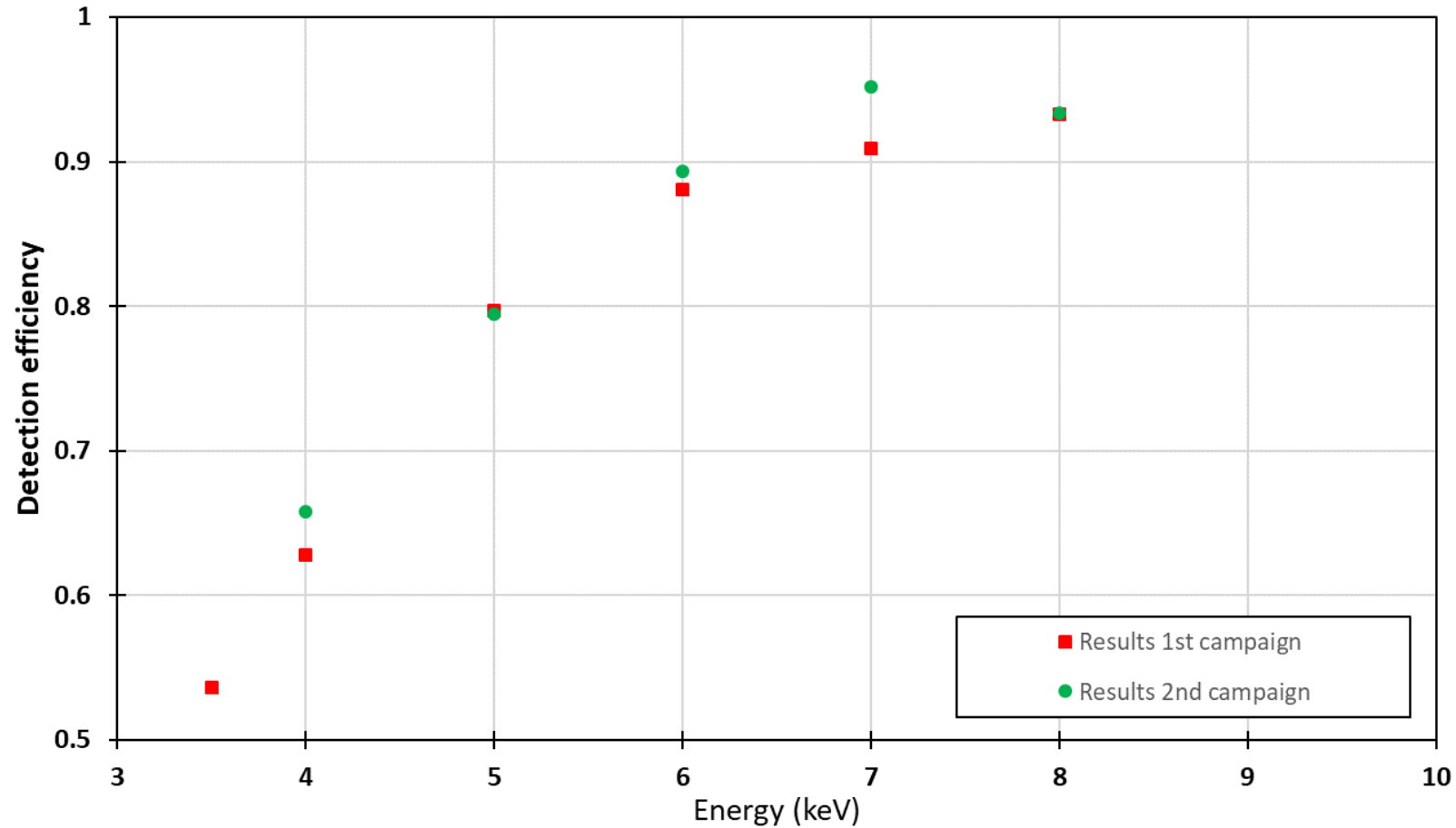
2nd step, with a much lower photon flux ($\sim 10^3$ ph/s)



Measurements to calibrate a HPGe detector



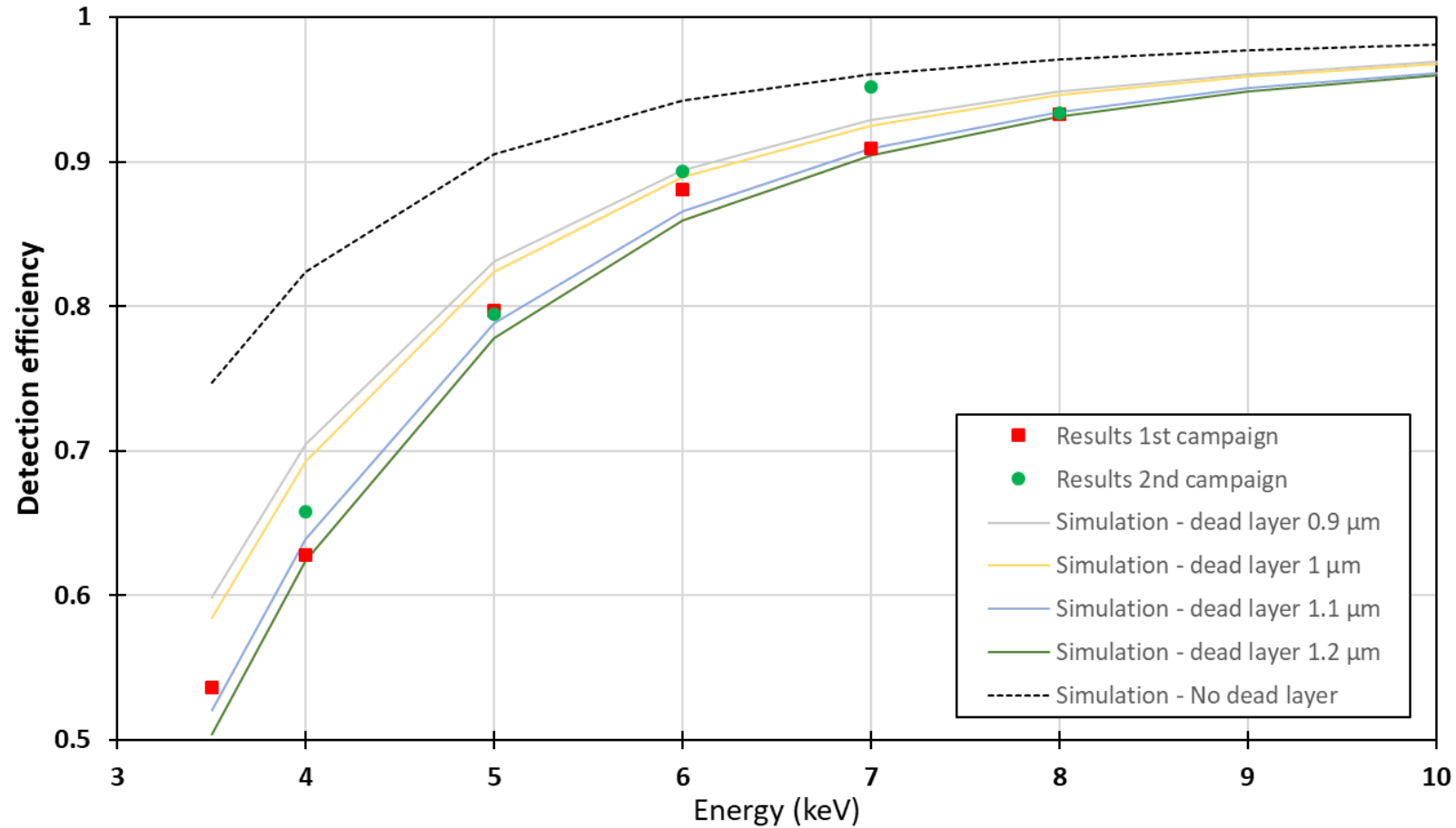
Results for 3.5 keV – 8 keV



Measurements to calibrate a HPGe detector

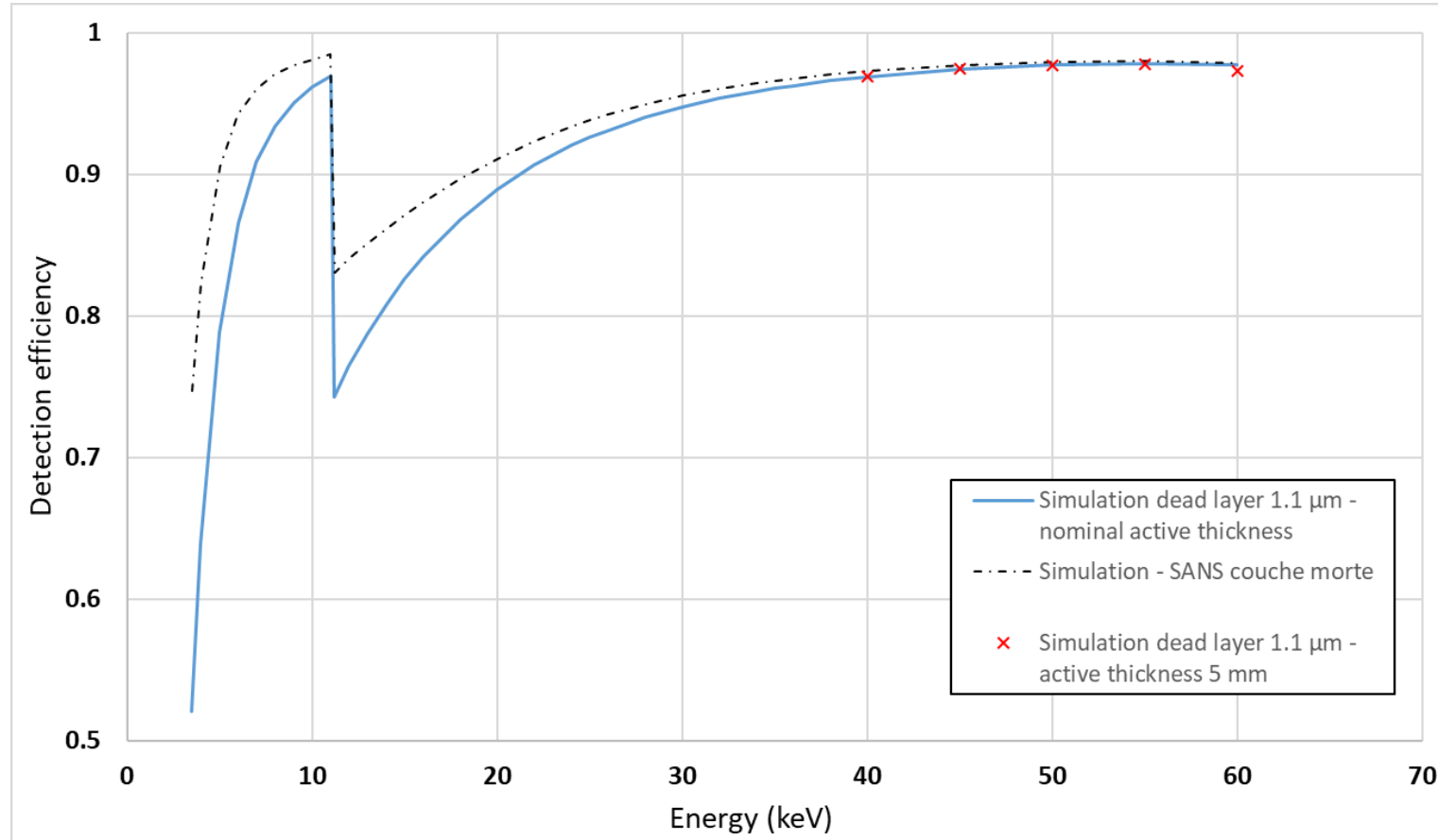


Optimisation of the dead layer



Exploiting experimental results

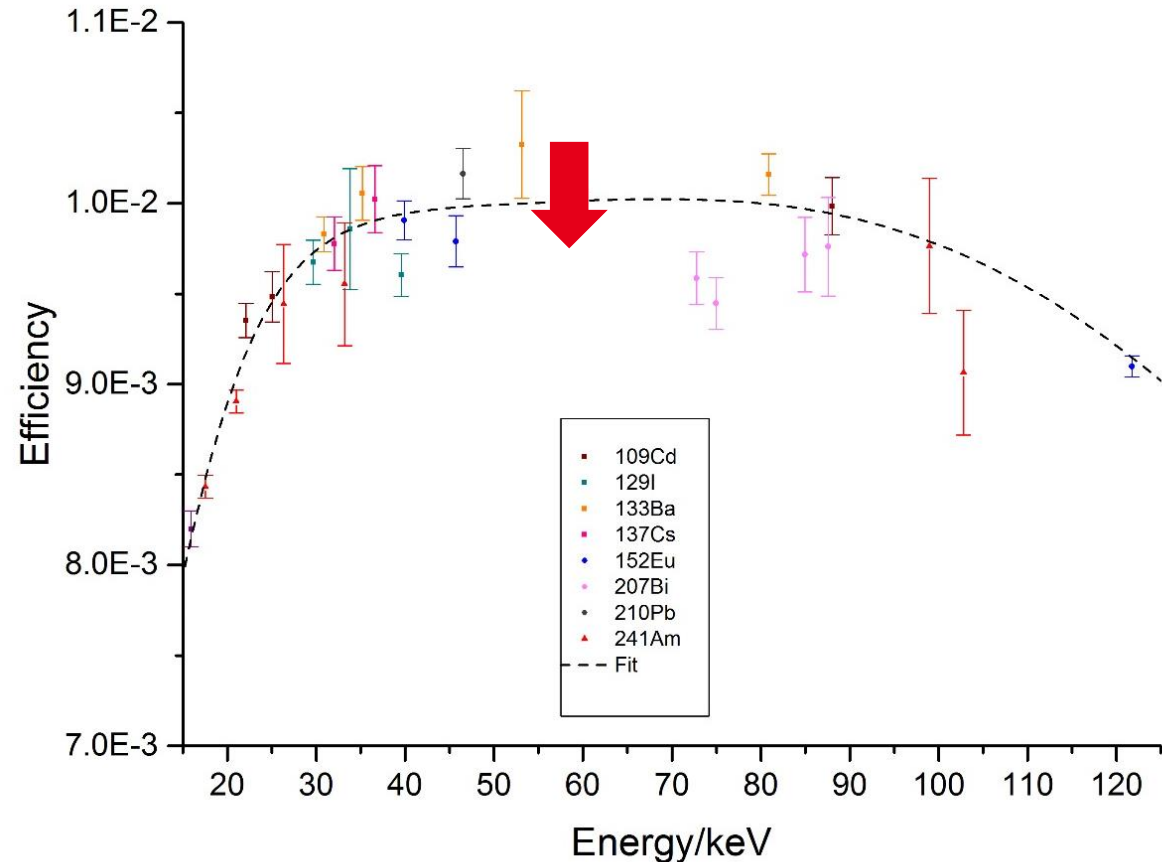
Extension of the energy interval
via Monte Carlo simulations



Application to the determination of photon emission intensities

Preliminary measurement of I_γ 53 keV of ^{133}Ba

I_γ (53 keV) ^{133}Ba	
DDEP 2004	2.14 (3)
DDEP 2016	2.14 (6)
This work	2.25
Lépy et al. (2018) *	2.229 (23)



* M.-C. Lépy, L. Brondeau, Y. Ménesguen, S. Pierre, J. Riffaud
Appl. Radiat. Isot., 134 (2018), pp. 131-136

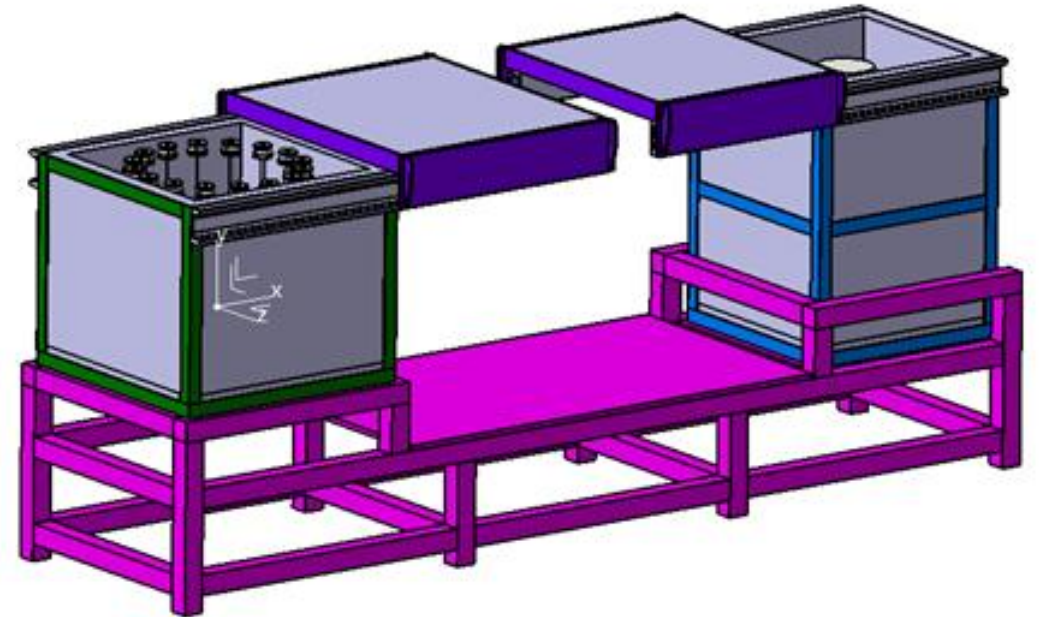
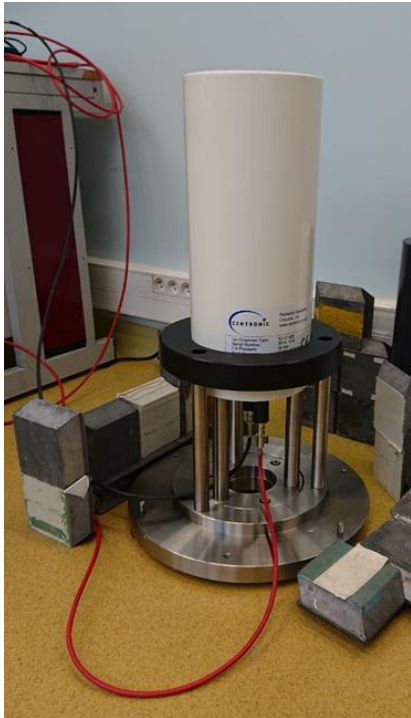


2 ■ Half-life measurements

Half-life measurements

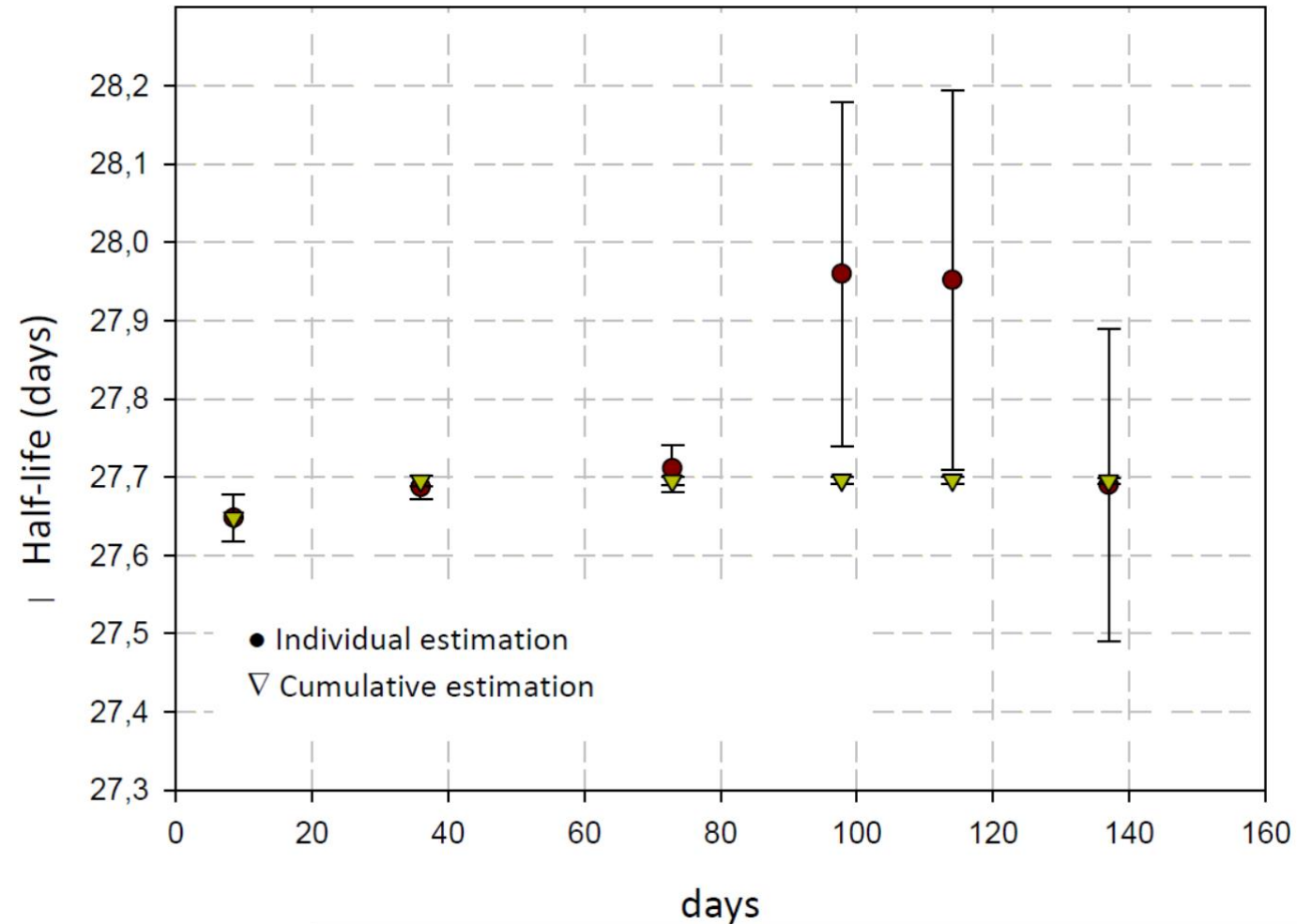
Development of a dedicated half-life measurement system using a well-type ionisation chamber

Measurement of the half-life of a number of radionuclides (^{51}Cr , ^{67}Ga and $^{99\text{m}}\text{Tc}$)

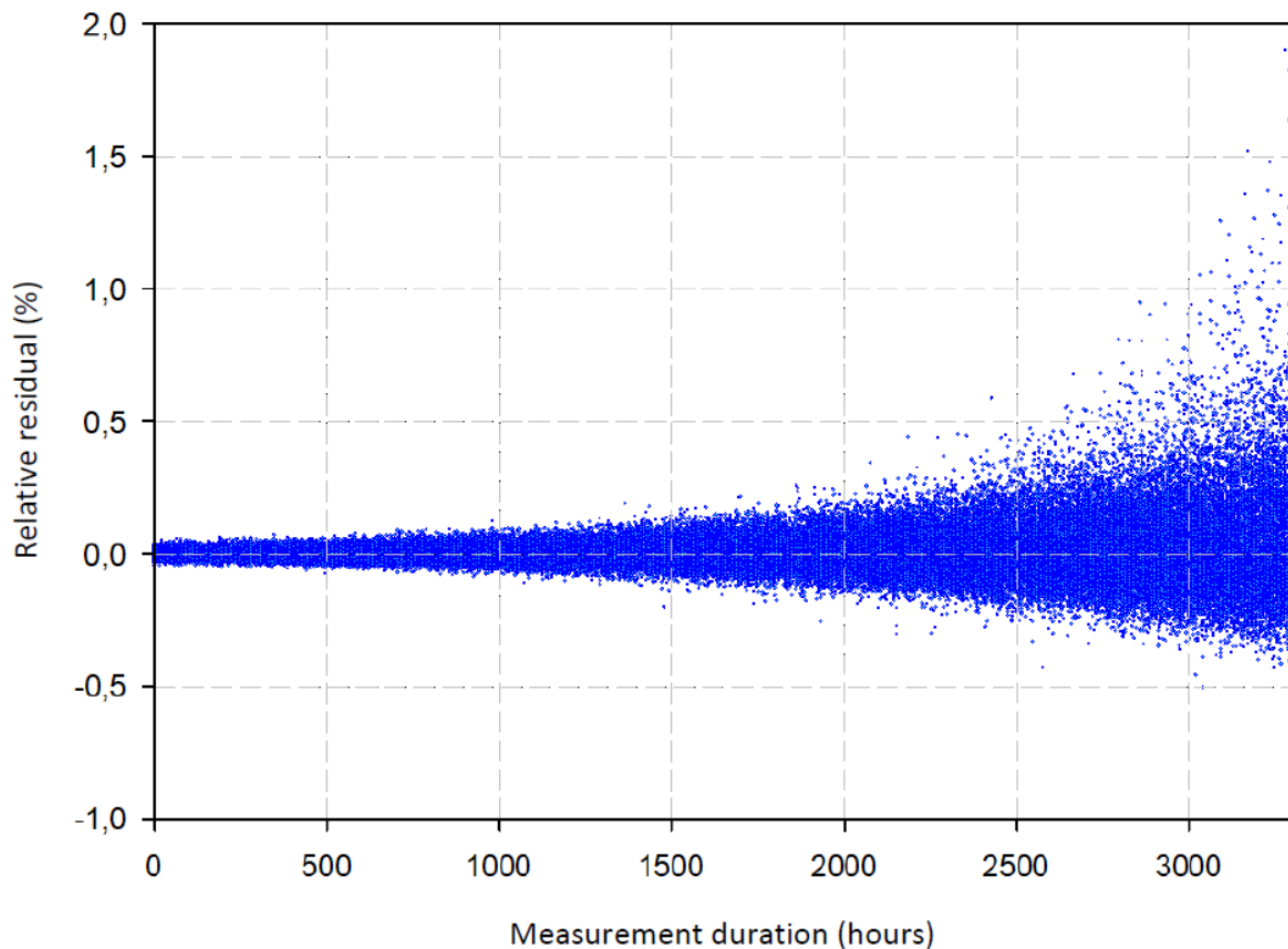


Half-life measurements: ^{51}Cr

Evaluated half-life (from DDEP) is 27.704 (4) d



Half-life measurements: ^{51}Cr

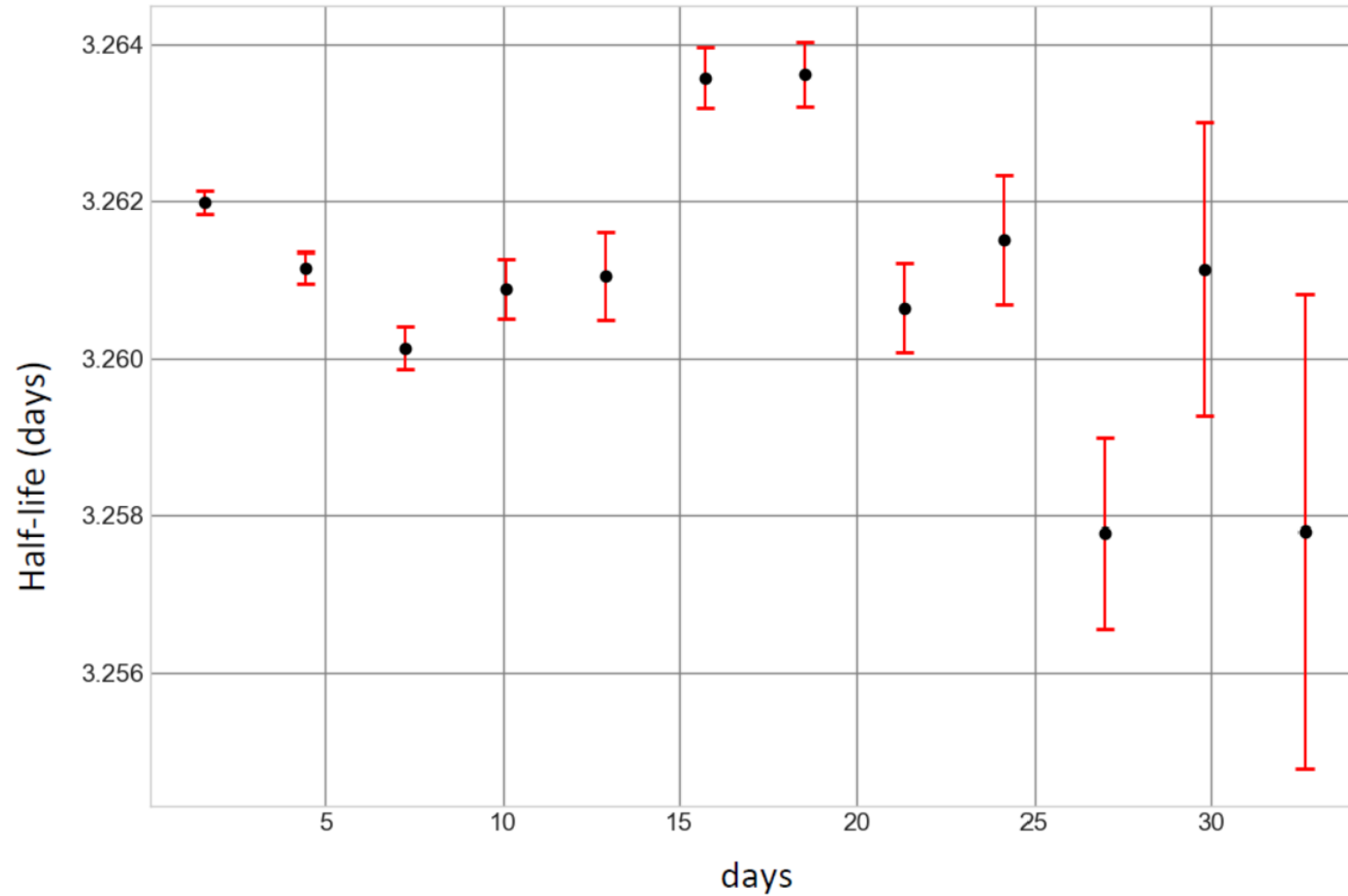


Component	$u(T_{1/2}) / \%$
Statistical	0.02
Time variation and linearity	0.04
Background correction	0.04
Relative uncertainty	0.06

Evaluated value: 27.704 (4) d

Our measurement: 27.695 (17) d

Half-life measurements: ^{67}Ga



Evaluated value: 3.2613 (5) d

Our measurement: 3.2614 (5) d

Outlook and conclusions

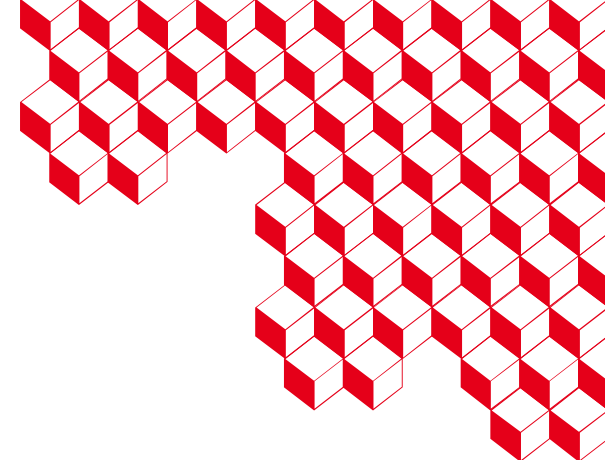
Successfully accomplished

Absolute γ -ray emission intensity measurements

- Set-up of cryogenic radiometer *BOLUX*
- Absolute measurement of synchrotron photon flux intensities
- Determination of the intrinsic efficiency of a HPGe in the energy range where the thickness of the dead layer is critical
- Extrapolation of the efficiency curve via Monte Carlo simulations to the whole energy range where the active thickness is not critical (3 - 55 keV)
- Measurement of ^{133}Ba γ -ray emission intensity at 53 keV – improvement of the calibration curve for our HPGe

Half-life measurements

- Development of a dedicated measurement system, based on a well-type ionisation chamber
- Improvement of analysis tools based on Python and uncertainty budget estimation
- Measurement of the half-life for a number of radionuclides



Thank you for your attention

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